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# Scheduling Independent Tasks with Voltage Overscaling

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## Scheduling Independent Tasks with Voltage Overscaling

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**Abstract:** In this paper, we discuss several scheduling algorithms to execute independent tasks with voltage overscaling algorithms. Given a frequency to execute the tasks, operating at a voltage below threshold leads to significant energy savings but also induces iming errors. A verification mechanism must be enforced to detect these errors. Contrarily to fail-stop or silent errors, timing errors are deterministic (but unpredictable). For each task, the general strategy is to select a voltage for execution, to check the result, and to select a higher voltage for re-execution if a timing error has occurred, and so on until a correct result is obtained. Switching from one voltage to another incurs a given cost, so it might be efficient to try and execute several tasks at the current voltage before switching to another one. Determining the optimal solution turns out to be unexpectedly difficult. However, we provide the optimal algorithm for a single task, the optimal algorithm when there are only two voltages, and the optimal level algorithm for several tasks, where a level algorithm is defined as an algorithm that executes all remaining tasks when switching to a given voltage.

Furthermore, we show that the optimal level algorithm is in fact globally optimal (among all possible algorithms) when voltage switching costs are linear. Finally, we report a comprehensive set of simulations to assess the potential gain of voltage overscaling algorithms.

Key-words: HPC, Resilience, Failures, Timing Errors, Voltage Overscaling, Energy Efficiency

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## Ordonnancement de tâches indépendantes avec réduction drastique du voltage

Résumé : Dans cet article, nous présentons plusieurs algorithmes d'ordonnancement pour exécuter des tâches indépendantes avec réduction drastique du voltage. Etant donné une fréquence pour exécuter les tâches, opérer à un voltage en dessous du seuil limite entraîne des économies d'énergie significatives, mais induit également des erreurs de synchronisation. Un mécanisme de vérification doit être utilisé pour détecter ces erreurs. Contrairement aux pannes ou aux erreurs silencieuses, les erreurs de synchronisation sont déterministes (mais imprévisible). Pour chaque tâche, la stratégie générale consiste à sélectionner un voltage pour l'exécution, à vérifier le résultat, à sélectionner un voltage plus élevée pour ré-exécution si une erreur de synchronisation a eu lieu et ainsi de suite jusqu'à ce qu'un résultat correct soit obtenu. Passer d'un voltage à un autre entraîne un coût donné, de sorte qu'il pourrait être efficace d'exécuter plusieurs tâches au voltage courant avant d'en changer. Déterminer la solution optimale se révèle étonnamment difficile. Cependant, nous fournissons l'algorithme optimal pour une seule tâche, l'algorithme optimal lorsqu'il n'y a que deux voltages, et l'algorithme à niveaux optimal pour plusieurs tâches, où un algorithme à niveaux est défini comme étant un algorithme qui exécute toutes les tâches restantes lors du passage à un voltage donnée.

En Outre, nous montrons que l'algorithme à niveaux optimal est en fait globalement optimal (parmi tous les algorithmes possibles) lorsque les coûts de changement de voltage sont linéaires. Enfin, nous présentons un ensemble exhaustif de simulations afin d'évaluer le gain potentiel de chaque algorithme avec réduction drastique du voltage.

Mots-clés : HPC, Tolérance aux pannes, Erreurs de temporisation, Réduction drastique du voltage, Efficacité énergétique

## 1 Introduction

Energy minimization has become a critical concern in High Performance Computing (HPC). Many authors have suggested to use *Dynamic Voltage and Frequency Scal*ing (*DVFS*) to reduce the energy consumption during the execution of an application. Reducing the frequency (or speed) at which each core is operated is the most frequently advocated approach, and great savings have been demonstrated for a variety of scientific applications [7, 1, 4, 13]. However, reducing the voltage for a given speed may lead to even greater savings, because the total consumed power is proportional to the square of the voltage. On the contrary, the dynamic power is linearly proportional to the frequency, and the static power is independent of it.

Keeping the same frequency and reducing the voltage is a promising direction which we explore in this paper. There is no free lunch, though. Given a frequency, there is always a voltage recommended by the manufacturer, below which it might be unsafe to operate the core. This voltage always includes some environmental margin to be on the safe side. Near-threshold computing is a technique that consists in reducing the voltage below the recommended value, down to a threshold voltage  $V_{\text{TH}}$  (also called *nominal voltage*) that is still considered safe. Overscaling algorithms suggest to further reduce the operating voltage, at the risk of producing *timing errors*. Because the voltage is set to a very low value, the results of some logic gates could be used before their output signals reach their final values, which could possibly lead to an incorrect result. The occurrence of a timing error depends upon many parameters: the voltage and frequency, and the nature of the target operation: different operations within the ALU may have different critical-path lengths. But in addition, for a given operation, different sets of operands may lead to different critical-path lengths (to see this, take a simple addition and think of a carry rippling to different gates depending upon the operands). Timing errors are therefore very different from usual fail-stop failures or silent errors that are dealt with in the literature: they are not random but, instead, they are purely deterministic. Indeed, replaying the same operation with the same set of operand under the same conditions will lead to the same result. Although deterministic, timing errors are unpredictable, because it is not possible to test all possible operands for a given operation. Therefore, for a given operation<sup>1</sup>, an error probability is associated to each voltage and represents the fraction of operands for which incorrect results will be produced by executing that operation on these operands at that voltage.

We need to take actions to mitigate the timing errors striking when voltage is aggressively lowered. After executing a task, we insert a verification mechanism to check the correctness of the result. In our study, the scheduling algorithms are agnostic of the nature of this verification mechanism, which could be anything from (costly) duplication to (cheap) checksumming and other applicationspecific methods. Of course the cheaper the cost of the verification, the smaller the overhead to total execution time.

To execute a given task, scheduling algorithms with voltage overscaling operate as follows: they are given a (discrete) set of possible voltages to operate with, and one of them as an input voltage. The first decision to take is whether to execute the task at that voltage or to choose another one. In the latter case, there is a switching cost to pay to change voltage. Regardless of the decision, the result is verified after the execution of the task. If the verification mechanism returns that the result is correct, we are done. If not, we need to re-execute the task. Remember that timing errors are deterministic: there is no point in re-executing the task with the same voltage, we know that we will get the same error. We need to select a higher voltage that will reduce the probability of failure, paying a switching cost, and re-execute the task with this voltage. Because the voltage is higher, the error probability is reduced, and we have a chance that the second execution is correct. The higher the second voltage, the better that chance, but the higher the cost of the execution, so there is a trade-off to achieve. If we are unlucky, we may have to try several higher and higher voltages, up to eventually finishing by using the threshold voltage, which is 100%safe but very costly. In Section 4, we give the optimal scheduling algorithm for a single task, extending our previous result [3] to the case where an input voltage is given to the algorithm.

The problem gets more complicated when there are many tasks to schedule. We assume that these tasks correspond to the same operation but involve different operands (think of a collection of matrix products or stencil updates). Given a voltage, each task has the same probability to fail. In the absence of switching costs (an unrealistic assumption in practice), the tasks can be dealt with independently. However, to amortize the switching cost from a given voltage to a new one, it might be a good idea to try and execute several tasks (or even all the remaining tasks) at a given voltage. One key contribution of this work is to analyze *level algorithms*, which always execute all the remaining tasks once a voltage has been selected. We provide a dynamic programming algorithm that computes the optimal level algorithm as a function of the input voltage costs and error probabilities, and of the number of tasks to execute.

Level algorithms turn out to be dominant among all possible algorithms when voltage switching costs are linear. Technically, if we have three voltages  $V_1 < V_2 < V_3$ , linear switching costs means that  $s_{1,3} = s_{1,2} + s_{2,3}$ , where  $s_{i,j}$  is the cost to switch from  $V_i$  to  $V_j$  (or the other way round, from  $V_j$  to  $V_i$ ). With linear switching costs, we show that the optimal level algorithm is in fact optimal among all possible algorithms, not just linear ones.

 $<sup>^1{\</sup>rm and}$  a given frequency: remember that throughout the text, we assume the frequency to be given.

Finally, an important contribution of the paper is to experimentally assess the usefulness of voltage overscaling algorithms. We first consider a case study from numerical linear algebra, where tasks are matrix-products that can be verified through ABFT checksums. We then envision different scenarios where we study the impact of each parameter (verification cost, voltage cost and error probability, switching costs). In addition to the gain in energy consumption, we also investigate the performance degradation: while we keep the same frequency (thereby avoiding a global slowdown of the execution as is the case with DVFS), we do have two sources of performance overhead: (i) the verification mechanism, and (ii) the time lost due to re-execution(s) and voltage switching after timing errors.

To the best of our knowledge, this paper (together with our initial workshop paper [3]) is the first algorithmic approach for voltage overscaling. Previous studies are hardware oriented and require special hardware mechanisms to detect timing errors [9, 11, 10, 5]. On the contrary, we propose scheduling algorithms that can be called by the operating system of the platform.

The rest of this paper is organized as follows. In Section 2, we introduce a formal model for timing errors. Then in Section 3, we illustrate several scheduling strategies by working out a couple of toy examples. We present the optimal algorithm for a single task in Section 4, and move to scheduling several tasks in Section 5. We report the results of a comprehensive set of simulations to assess the impact and benefits of the previous voltage overscaling algorithms in Section 6. Finally, we provide concluding remarks in Section 7.

#### 2 Model

We now present a formal model for timing errors. We introduce the main notations and assumptions, and investigate the impact of timing errors on the success and failure probabilities of tasks. Because timing errors are deterministic, conditional properties are completely different from what is usually enforced for the resilience of HPC applications.

#### 2.1 Timing errors

As already mentioned, we focus on a fixed frequency environment (this frequency may have been chosen to achieve a given performance). Then timing errors depend upon the voltage selected for execution, and we model this with the following two assumptions:

Assumption 1. Given an operation and an input I (the set of operands), there exists a threshold voltage  $V_{\text{TH}}(I)$ : using any voltage V below the threshold ( $V < V_{\text{TH}}(I)$ ) will always lead to an incorrect result, while using any voltage above that threshold ( $V \ge V_{\text{TH}}(I)$ ) will always lead to Assumption 2. When an operation is executed under a given voltage V, there is a probability  $p_V$  that the computation will fail, i.e., produces at least one error, on a random input. This failure probability is computed as  $p_V = |\mathcal{I}_f(V)|/|\mathcal{I}|$ , where  $\mathcal{I}$  denotes the set of all possible inputs and  $\mathcal{I}_f(V) \subseteq \mathcal{I}$  denotes the set of inputs for which the operation will fail at voltage V. Equivalently,  $\mathcal{I}_f(V)$  is the set of inputs whose threshold voltages are strictly larger than V, according to Assumption 1. For any two voltages  $V_1$  and  $V_2$  with  $V_1 \geq V_2$ , we have  $\mathcal{I}_f(V_1) \subseteq \mathcal{I}_f(V_2)$  (Assumption 1), hence  $p_{V_1} \leq p_{V_2}$ .

If a task consists of t identical operations, each executed at voltage V with error probability  $p_V$ , then the probability of successful execution of the task is  $(1 - p_V)^t$ : the larger the task, the greater the risk. Since timing errors are essentially silent errors, they do not manifest themselves until the corrupted data has led to an unusual application behavior, which may be detected long after the error has occurred, wasting the entire computation done so far. Hence, an error-detection mechanism (also called *verification* mechanism) is necessary to ensure timely detection of timing errors after the execution of each task. In this paper, we assume that this mechanism is given. All the algorithms presented in Sections 4 and 5 are fully general and agnostic of the error-detection technique (checksum, error correcting code, coherence tests, etc.).

#### 2.2 Notations

We consider a set  $\mathcal{T} = \{T_1, T_2, \cdots, T_n\}$  of n tasks to be executed by the system. All tasks share the same computational weight, including the work to verify the correctness of the result at the end. Hence, all tasks have the same execution time and energy consumption under a fixed voltage. We apply Dynamic Voltage OverScaling (DVOS) to tradeoff between energy cost and failure probability. The platform can choose an operating voltage among a set  $\mathcal{V} = \{V_1, V_2, \cdots, V_k\}$  of k discrete values, where  $V_1 < V_2 < \cdots < V_k$ . Each voltage  $V_{\ell}$  has an *en*ergy cost per task  $c_{\ell}$  that increases with the voltage, i.e.,  $c_1 < c_2 < \cdots < c_k$ . Based on Assumption 2, each voltage  $V_\ell$  also has a *failure probability*  $p_\ell$  that decreases with the voltage, i.e.,  $p_1 > p_2 > \cdots > p_k$ . We assume that the highest voltage  $V_k$  equals the nominal voltage  $V_{\text{TH}}$  with failure probability  $p_k = 0$ , thus guaranteeing error-free execution for all possible inputs. For convenience, we also use a *null* voltage  $V_0$  with failure probability  $p_0 = 1$  and null energy cost  $c_0 = 0$ . Here is a summary of these notations:

Voltages	$V_0$	$V_1$	$V_2$	 $V_k = V_{\text{TH}}$
Failure Prob.	$p_0 = 1$	$p_1$	$p_2$	 $p_k = 0$
Energy cost	$c_0 = 0$	$c_1$	$c_2$	 $c_k$

We further assume that DVOS is only applied to reduce energy consumption, and leaving the system at a voltage below  $V_{\rm TH}$  after the execution of the task(s) is not allowed input is randomly chosen (we have no a priori knowledge (because it would not be safe). This is formally stated in the following assumption.

Assumption 3. The system is initially running at nominal voltage  $V_{\rm TH}$  and its voltage must be reset back to  $V_{\rm TH}$ when all computations are done.

Switching the operating voltage also incurs an energy cost. Let  $s_{\ell,h}$  denote the energy consumed to switch the system's operating voltage from  $V_{\ell}$  to  $V_h$ . We have  $s_{\ell,h} =$ 0 if  $\ell = h$  and  $s_{\ell,h} > 0$  if  $\ell \neq h$ . Moreover, we make the following assumptions on the properties of the switching costs, which are true in many systems in practice:

**Assumption 4.** The voltage switching costs of the system satisfy to:

• Symmetry:  $s_{\ell,h} = s_{h,\ell}$  for all  $V_\ell, V_h \in \mathcal{V}$ ;

• Dominance:  $s_{\ell,h} \ge s_{\ell,p}$  and  $s_{\ell,h} \ge s_{p,h}$  for  $V_{\ell} \le V_p \le$  $V_h$ ;

• Triangle inequality:  $s_{\ell,h} \leq s_{\ell,p} + s_{p,h}$  for  $V_{\ell} \leq V_p \leq V_h$ .

Definition 1 (Linear switching costs). We have linear costs when the triangle inequality is always an equality:  $s_{\ell,h} = s_{\ell,p} + s_{p,h}$  for all  $V_{\ell} \leq V_p \leq V_h$ .

The objective is to minimize the expected total energy consumption by determining the optimal strategy to execute the set of tasks.

#### 2.3Success and failure probabilities

We now consider the implications of Assumptions 1 and 2 on the success and failure probabilities of executing a task following a sequence of voltages. For the ease of writing, we assume that the execution of each task has already failed under the null voltage  $V_0$  (at energy cost  $c_0 = 0$ ).

**Lemma 1.** Consider a sequence  $\langle V_1, V_2, \cdots, V_m \rangle$  of m voltages, where  $V_1 < V_2 < \cdots < V_m$ , under which a given task is executed. For any voltage  $V_{\ell}$ , where  $1 \leq \ell \leq m$ , given that the execution of the task on a certain input has already failed under voltages  $V_0, V_1, \cdots, V_{\ell-1}$ , the probability that the task execution will fail or succeed under voltage  $V_{\ell}$  on the same input is

$$\mathbb{P}(V_{\ell}\text{-fail} \mid V_0 V_1 \cdots V_{\ell-1}\text{-fail}) = \frac{p_{\ell}}{p_{\ell-1}} ,$$
  
$$\mathbb{P}(V_{\ell}\text{-succ} \mid V_0 V_1 \cdots V_{\ell-1}\text{-fail}) = 1 - \frac{p_{\ell}}{p_{\ell-1}} .$$

*Proof.* We prove the probabilities using Assumptions 1 and 2. The task under study is the execution of some computation on some input I. Since this task execution has failed under voltages  $V_0, V_1, \dots, V_{\ell-1}$ , we know that input I satisfies  $I \in \bigcap_{h=0}^{\ell-1} \mathcal{I}_f(V_h) = \mathcal{I}_f(V_{\ell-1}) (\mathcal{I}_f(V_h))$  is the set of inputs on which the computation fails under voltage  $V_h$ ). Then, the task execution will fail again under voltage  $V_{\ell}$  if the input satisfies  $I \in \mathcal{I}_f(V_{\ell}) \subseteq \mathcal{I}_f(V_{\ell-1})$ . Otherwise, the task execution will succeed. Given that the

on it), the failure probability is

$$\begin{split} \mathbb{P}(V_{\ell}\text{-fail} \mid V_0 V_1 \cdots V_{\ell-1}\text{-fail}) \\ &= \frac{|\mathcal{I}_f(V_{\ell})|}{|\mathcal{I}_f(V_{\ell-1})|} = \frac{|\mathcal{I}_f(V_{\ell})|/|\mathcal{I}|}{|\mathcal{I}_f(V_{\ell-1})|/|\mathcal{I}|} = \frac{p_{\ell}}{p_{\ell-1}} \ , \end{split}$$

and the success probability is

$$\begin{split} \mathbb{P}(V_{\ell}\text{-succ} \mid V_0 V_1 \cdots V_{\ell-1}\text{-fail}) \\ &= \frac{|\mathcal{I}_f(V_{\ell-1}) \setminus \mathcal{I}_f(V_{\ell})|}{|\mathcal{I}_f(V_{\ell-1})|} = 1 - \frac{|\mathcal{I}_f(V_{\ell})|}{|\mathcal{I}_f(V_{\ell-1})|} = 1 - \frac{p_{\ell}}{p_{\ell-1}} \;. \end{split}$$

#### 3 **Examples**

In this section, we focus on the special case where there are only two available voltages (k = 2). In the first study, for the sake of illustration, we assume that Assumption 3 does not hold and that the system is originally at voltage  $V_1$ . In the second study, we derive the optimal policy, for two voltages, assuming that Assumption 3 holds (which will always be the case in the following sections).

#### 3.1Two voltages without Assumption 3

The system is initially at voltage  $V_1$ . We assume that there are only two tasks to execute. It is twice as expensive energy-wise to execute a task at  $V_2$  than at  $V_1$  ( $c_1 = 1$  and  $c_2 = 2$ ), the failure probability at  $V_1$  is 80% ( $p_1 = 0.8$ ), and switching voltage from  $V_1$  to  $V_2$  is as expensive as executing 20 tasks at  $V_1$  ( $s_{1,2} = 20$ ). If there were no switching costs  $(s_{1,2} = 0)$ , no task would be executed at voltage  $V_1$ . Indeed, executing a task at voltage  $V_2$  costs  $c_2 = 2$ , when the expected cost of executing a task at  $V_1$ is  $c_1 + p_1 \cdot c_2 = 1 + 0.8 \cdot 2 = 2.6$ . If we could switch voltages for free, we would always switch to the nominal voltage to execute tasks. However, the switching cost is expensive, here, and the system is initially at voltage  $V_1$ . We can envision three policies:

- Switch directly to  $V_2$  to execute both tasks. This costs:  $s_{1,2} + 2 \cdot c_2 = 24$ .
- Execute each task at  $V_1$ . If all executions succeed (which happens with probability  $(1 - p_1)^2$ ), we are done. Otherwise, switch to  $V_2$  and re-execute the  $(p_1)^2)s_{1,2} + 2 \cdot p_1 \cdot c_2 = 24.4.$
- Execute the first task at  $V_1$  and switch to  $V_2$  after its completion if and only if its execution failed. The rationale is as follows. If the execution of the first task fails, whatever the result of the execution of the second task we will have to switch to  $V_2$  to re-execute the first task. Moreover, we have shown that executing a task at  $V_2$  is cheaper than trying to execute it at  $V_1$  and then re-execute it at  $V_2$  in case of

failure. Therefore, we save energy by not attempting to execute the second task at  $V_1$ . If the execution of the first task was successful, we remain at  $V_1$  in (the unlikely) case that the execution of the second case will also succeed and that we will never have to switch to  $V_2$  (thus saving the huge switching cost). The expected cost of this policy is then:  $c_1+p_1(s_{1,2}+2\cdot c_2)+(1-p_1)(c_1+p_1(s_{1,2}+c_2))=23.92$ . The third policy is optimal in this case. This example illustrates two important facts: (i) the optimal policy may be dynamic, the decision at which voltage the next task should be executed depending on the success or failure of other tasks; (ii) switching costs can have a significant impact on the shape of the optimal solution.

#### 3.2 Two voltages under Assumption 3

We now assume that we have n tasks to process, and that Assumption 3 holds (as it should). We have two cases to consider, whether  $V_1$  is used or not.

- $V_1$  is not used. The cost is then  $n \cdot c_2$ .
- $V_1$  is used. Then, whatever the policy, the two switching costs  $s_{1,2}$  and  $s_{2,1}$  will be payed. Executing a task at voltage  $V_2$  costs  $c_2$ . Executing a task first at voltage  $V_1$  costs:  $c_1 + p_1 \cdot c_2$ . Therefore, it may only be worth using  $V_1$  if  $c_1 + p_1 \cdot c_2 \leq c_2 \Leftrightarrow c_1 \leq (1 p_1)c_2$ . In this case, an optimal solution is to first execute all tasks at  $V_1$ , then the voltage must be switched back to  $V_2$  and, finally, failed tasks must be reexecuted. Indeed, whatever happens, both switching costs are paid, the solution is the same as if switching costs were zero The expected cost is then:  $2s_{1,2} + n \cdot c_1 + n \cdot p_1 \cdot c_2$ . This is better than the first policy if and only if:

$$n \cdot c_2 \ge 2s_{1,2} + n \cdot c_1 + n \cdot p_1 \cdot c_2 \Leftrightarrow n \ge \left\lceil \frac{2s_{1,2}}{c_2(1-p_1)-c_1} \right\rceil$$

The optimal strategy is thus: if  $c_1 \leq (1-p_1)c_2$  and  $n \geq \lfloor \frac{2s_{1,2}}{c_2(1-p_1)-c_1} \rfloor$ , then switch to  $V_1$ , execute all tasks at  $V_1$ , switch to  $V_2$  and re-execute all failed tasks; otherwise, stay at  $V_2$  and execute all tasks at that voltage. Hence, the shape of the optimal strategy depends of the number of tasks to execute. Note that thanks to Assumption 3, the shape of the solution is simpler than in the previous study.

### 4 Scheduling for a single task

We focus here on the special case where there is only one task to execute. We present an optimal algorithm for this case, extending our previous result [3] to the case where an input voltage is given to the algorithm. We need this extension to prepare for the general case with several tasks: indeed, consider a simple algorithm that proceeds task after task. For the first task, the input voltage is always  $V_{\text{TH}}$ , according to Assumption 3. But when the execution

of the first task completes, the input voltage for the second task may well be different from  $V_{\text{TH}}$ , if for instance the algorithm tried, and succeeded with, a lower voltage.

We first define some notations. Let  $E_{\text{ONE}}^*(V_h, V_\ell)$  denote the optimal expected energy needed to execute the task starting from voltage  $V_h$ , given that the task has previously failed under a sequence of lower voltages, the highest one among which is  $V_\ell$ . Let  $E_{\text{ONE}}^*(V_\ell)$  and  $V_{\text{ONE}}^*(V_\ell)$ denote, respectively, the optimal expected energy and the optimal voltage needed to execute the task after it has just failed under voltage  $V_\ell$ . The following theorem shows the optimal solution:

**Theorem 1.** To execute a single task on a system with k voltages, the optimal expected energy consumption as well as the optimal sequence of voltages can be obtained by dynamic programming with complexity  $O(k^2)$ .

Proof. Suppose the task has just failed under voltage  $V_{\ell}$ and it is about to be executed at a higher voltage  $V_h > V_{\ell}$ . According to Lemma 1, the probability that the tasks will fail again under  $V_h$  is given by  $\mathbb{P}(V_h\text{-fail} | V_{\ell}\text{-fail}) = p_h/p_{\ell}$ . If the task is successfully completed at  $V_h$ , we can just reset the voltage from  $V_h$  back to the nominal voltage  $V_{\text{oNE}}(V_h)$  to continue executing the task until successful completion. Thus, for any pair  $(V_h, V_{\ell})$  of voltages with  $V_0 \leq V_{\ell} < V_h \leq V_k$ , we can compute  $Eone^*(V_h, V_{\ell})$  by the following dynamic programming formulation:

$$E_{\text{one}}^*(V_h, V_\ell) = c_h + \left(1 - \frac{p_h}{p_\ell}\right) s_{h,k}   
+ \frac{p_h}{p_\ell} \cdot \min_{h (1)$$

The table is initialized with  $E^*_{\text{ONE}}(V_k, V_\ell) = c_k$  regardless of  $V_\ell$ , and the entire table can be computed in  $O(k^2)$  time.

The optimal expected energy to execute the task after it has just failed under voltage  $V_{\ell}$  is therefore

$$E_{\rm ONE}^{*}(V_{\ell}) = \min_{\ell < h \le k} \left\{ s_{\ell,h} + E_{\rm ONE}^{*}(V_{h}, V_{\ell}) \right\}, \qquad (2)$$

and the optimal voltage to execute the task in this case is  $V_{\text{ONE}}^*(V_{\ell}) = V_{h'}$ , where  $h' = \arg\min_{\ell < h \le k} \{s_{\ell,h} + E_{\text{ONE}}^*(V_h, V_{\ell})\}$ . Again, computing  $E_{\text{ONE}}^*(V_{\ell})$  and  $V_{\text{ONE}}^*(V_{\ell})$ for all  $1 \le \ell \le k$  takes  $O(k^2)$  time. The optimal expected energy to execute the task from the initial nominal voltage  $V_k$  is thus:

$$E_{\text{ONE}}^{*} = \min_{1 \le h \le k} \left\{ s_{k,h} + E_{\text{ONE}}^{*}(V_{h}, V_{0}) \right\}$$

where  $V_0$  is the null voltage with failure probability  $p_0 = 1$ . The optimal starting voltage to execute the task is  $V_{\text{ONE}}^* = V_{h'}$ , where  $h' = \arg \min_{1 \le h \le k} \{s_{k,h} + E_{\text{ONE}}^*(V_h, V_0)\}$ . This can be computed in O(k) time.

## 5 Scheduling for several tasks

We now consider the general case of executing a set of n independent tasks, where  $n \geq 2$ . All tasks correspond to the same computational operations, but may have different threshold voltages, because they operate on different data sets. The problem turns out to be more complicated than expected. We start, in Section 5.1, with the introduction of two simple scheduling strategies, task-by-task and *level*, before sketching the description of a general scheduling algorithm. Then we show how to determine the optimal level algorithm in Section 5.2. Finally, in Section 5.3, we prove that the optimal level algorithm is in fact globally optimal among all possible scheduling algorithms when switching costs are linear.

#### 5.1 Scheduling algorithms and strategies

We now provide an informal description of scheduling algorithms for independent tasks. There are two simple execution strategies, which we call task-by-task and level. The task-by-task strategy considers the tasks one after the other, waiting for the successful completion of the current task before proceeding to the (first) execution of the next task. The task-by-task strategy relies upon the optimal algorithm for a single task and input voltage described in Section 4. After the successful execution of the current task, the platform voltage is set at some value  $V_h$ , which we use as input voltage for applying the optimal singletask algorithm to the execution of the next task.

While optimal for each task, this strategy may end up paying many switching costs. For instance, if the optimal single-task algorithm always starts with some low voltage, say  $V_s$ , regardless of the input voltage  $V_h$ , then the taskby-task strategy will have to switch back down to  $V_s$  each time there has been a timing error in the execution of the previous task.

To minimize switching costs, when given an input voltage, another strategy is to execute all tasks at that voltage, before switching to another voltage and execute all remaining tasks at that other voltage, and so on. This *level* strategy goes voltage-by-voltage instead of task-bytask, executing all tasks at a given voltage before switching to another one (hence its name).

While very natural, the task-by-task and level strategies are not the only possible algorithms. In fact, a general scheduling algorithm proceeds as follows. At each step, we are given an input voltage (that of the last execution of a task, or  $V_{\rm TH}$  initially) and the list of remaining tasks, together with their history (the last voltage tried for execution of each task is recorded, with  $V_0$  for initial condition). Then the algorithm selects one task in the list and one voltage  $V_{\rm new}$  higher than the one recorded for this task<sup>2</sup>, and executes the task at that voltage. A switching cost is paid if  $V_{\text{new}}$  is different from the input voltage. If the execution is successful, the task is removed from the list, and otherwise, the task stays in the list, and its history is updated with  $V_{\text{new}}$  being recorded. The algorithm then proceeds to the next step, with  $V_{\text{new}}$  as input voltage. The key decision at each step of the scheduling algorithm is the selection of the new task and voltage pair, and this decision may well depend upon the number and history of the tasks in the list, the input voltage, and all the problem parameters (cost and error probability of each voltage, and switching costs). Altogether, we have a complex decision to make at each step, and it seems very difficult to prove the optimality of a scheduling algorithm in the general case.

#### 5.2 Level algorithms

In this section, we formally define level algorithms, and we provide a dynamic programming algorithm to compute the optimal level algorithm.

**Definition 2** (Level algorithms). A level algorithm executes a set of independent tasks as follows:

- 1. Select the initial voltage V;
- 2. Switch to voltage V and execute all remaining tasks;
- 3. Remove the successfully completed tasks from the set;
- 4. If there are still some tasks not successfully completed chose the next, higher, voltage V to try and go to Step 2;
- 5. If the last voltage used is not  $V_k$ , switch to voltage  $V_k$ .

We call the sequence of voltages tried by a level algorithm the voltage sequence.

The level strategy guarantees that each voltage will be used at most once, so the voltages will not change more than k times during the execution of the entire set. We have to determine the optimal sequence of voltages to characterize the optimal level algorithm. Before presenting the dynamic programming algorithm that solves this problem, we need a few notations.

Let  $E_{\text{SET}}^*(i, V_h, V_\ell)$  denote the optimal expected energy needed to execute *i* tasks starting at voltage  $V_h$ , provided that these tasks have just failed under a lower voltage  $V_\ell < V_h$ . Then, the optimal expected energy to execute *i* tasks that have just failed under voltage  $V_\ell$  is given by  $E_{\text{SET}}^*(i, V_\ell) = \min_{\ell < h \le k} \{s_{\ell,h} + E_{\text{SET}}^*(i, V_h, V_\ell)\}.$ 

**Theorem 2.** To execute a set of n independent tasks on a system with k voltages, the optimal expected energy consumption as well as the next optimal voltage to execute a given number of tasks —which failed at a lower voltage or knowing that we are at nominal voltage and before any execution— can be obtained by dynamic programming with complexity  $O(n^2k^2)$ .

 $<sup>^2{\</sup>rm There}$  would be no point in trying the recorded voltage again, or a lower one: we know that the execution of the task would fail again.

*Proof.* Suppose a set of *i* tasks that have just failed under voltage  $V_{\ell}$  and that will be executed at a higher voltage  $V_h$ . According to Lemma 1, the probability that any of these tasks fails again at  $V_h$  is  $\mathbb{P}(V_h$ -fail |  $V_{\ell}$ -fail) =  $p_h/p_{\ell}$ . Thus, the probability that *j* tasks will remain uncompleted after they are all executed at voltage  $V_{\ell}$  is

$$\mathbb{P}(j \text{ tasks remain}) = {\binom{i}{j}} \left(\frac{p_h}{p_\ell}\right)^j \left(1 - \frac{p_h}{p_\ell}\right)^{i-j}$$

for any  $0 \leq j \leq i$ . If no task remains, e.g., j = 0, we need to reset the voltage from  $V_h$  back to the nominal voltage  $V_k$ . Otherwise, we need to determine the optimal voltage to execute the remaining j tasks. Hence, the dynamic program:

$$E_{\text{SET}}^{*}(i, V_h, V_\ell) = i \cdot c_h + \mathbb{P}(\text{no task remains}) \cdot s_{h,k}$$
$$+ \sum_{j=1}^{i} \left( \mathbb{P}(j \text{ tasks remain}) \min_{h 
$$= i \cdot c_h + \left( 1 - \frac{p_h}{p_\ell} \right)^i s_{h,k}$$
$$+ \sum_{j=1}^{i} \left( \binom{i}{j} \left( \frac{p_h}{p_\ell} \right)^j \left( 1 - \frac{p_h}{p_\ell} \right)^{i-j} \cdot \min_{h$$$$

for all  $1 \leq i \leq n$  and all  $(V_h, V_\ell)$  pairs with  $V_0 \leq V_\ell < V_h \leq V_k$ . In particular, when  $V_h = V_k$ , we have  $E^*(i, V_k, V_\ell) = i \cdot c_k$  for all  $1 \leq i \leq n$  regardless of  $V_\ell$ .

The optimal expected energy needed to execute i remaining tasks after they have just failed under voltage  $V_\ell$  is therefore

$$E_{\text{SET}}^{*}(i, V_{\ell}) = \min_{\ell < h \le k} \left\{ s_{\ell, h} + E_{\text{SET}}^{*}(i, V_{h}, V_{\ell}) \right\}.$$
 (3)

The optimal voltage to execute these tasks is  $V_{\text{SET}}^*(i, V_{\ell}) = V_{h'}$ , where  $h' = \arg \min_{\ell < h \leq k} \{s_{\ell,h} + E_{\text{SET}}^*(i, V_h, V_{\ell})\}$ . The optimal expected energy needed to execute all n tasks, given that the initial system voltage is the nominal voltage  $V_k$ , is

$$E_{\text{SET}}^* = \min_{1 \le h \le k} \left\{ s_{k,h} + E_{\text{SET}}^*(n, V_h, V_0) \right\} \,,$$

where  $V_0$  is the null voltage with failure probability  $p_0 = 1$ . The optimal starting voltage to execute the entire set is  $V_{\text{SET}}^* = V_{h'}$ , where  $h' = \arg \min_{1 \le h \le k} \{s_{k,h} + E_{\text{SET}}^*(n, V_h, V_0)\}$ .

The complexity is clearly dominated by the computation of  $E^*_{\text{SET}}(i, V_s, V_\ell)$  for all  $1 \le i \le n$ ,  $V_0 \le V_\ell < V_k$  and  $V_\ell < V_s \le V_k$ , which takes  $O(n^2k^2)$  time.

Theorem 2 shows that the optimal voltage to select after each iteration depends on the number of remaining tasks. To demonstrate this point, consider an example with three voltages and 10 independent tasks. The energy costs of the voltages are  $c_1 = 0.1$ ,  $c_2 = 1$  and  $c_3 = 5$ , and the corresponding error probabilities are  $p_1 = 0.8$ ,  $p_2 = 0.5$ 

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and  $p_3 = 1$ . The voltage switching costs are  $s_{1,2} = s_{2,3} = 1$ and  $s_{1,3} = 1.1$ . According to Theorem 2, the optimal voltage to start executing the tasks is  $V_1$ . Suppose  $V_1$  has been used. We consider the following two cases.

- Case 1: There is only 1 task left. In this case, switching first to  $V_2$  and in case of failure again to  $V_3$  incurs an expected cost of  $s_{1,2} + c_2 + \frac{p_2}{p_1}(s_{2,3} + c_3) + (1 \frac{p_2}{p_1})s_{2,3} = 6.125$ . On the other hand, switching directly to  $V_3$  incurs a total cost of  $s_{1,3} + c_3 = 6.1$ . Hence, the best strategy in this case is to switch directly to  $V_3$ .
- Case 2: There are 9 tasks left. Then, switching first to  $V_2$  and then to  $V_3$  incurs an expected cost of  $s_{1,2} + 9c_2 + \left(1 \frac{p_2}{p_1}\right)^9 s_{2,3} + \sum_{j=1}^{9} {9 \choose j} \left(\frac{p_2}{p_1}\right)^j \left(1 \frac{p_2}{p_1}\right)^{9-j} (s_{2,3} + j \cdot c_3) = 39.125.$  On the other hand, switching directly to  $V_3$  incurs a total cost of  $s_{1,3} + 9c_3 = 46.1$ . Hence, the best strategy in this case is to try voltage  $V_2$  first and then  $V_3$ .

Intuitively, using the intermediate voltage  $V_2$  pays off only when there are many tasks left, in which case the extra switching overhead diminishes with respect to the potential energy gained from task execution.

#### 5.3 Optimality result

In this section we prove that level algorithms are dominant when switching costs are linear. The analysis so far has assumed that the voltage switching cost follows triangle inequality. However, under the special case of linear costs, i.e.,  $s_{\ell,h} = s_{\ell,p} + s_{p,h}$ , we are able to show that there exists an algorithm that satisfies Definition 2 and which is optimal. Furthermore, the optimal voltage sequence has a much simpler structure, which helps reduce significantly the complexity of the optimal algorithm.

We first prove a simple result: when switching costs are zero, the optimal algorithm for a single task defines a level algorithm that is optimal for an arbitrary number of tasks. Intuitively, we can transform any task-by-task algorithm into a level algorithm with the same cost, because there is no overhead to switch voltages:

**Lemma 2.** On a system without voltage switching costs there exists an optimal algorithm which is a level algorithm such that after each voltage:

- The optimal voltage to execute the remaining tasks does not depend on the number of remaining tasks, and it is the same as the optimal voltage to execute a single task;
- The optimal expected energy consumption is proportional to the number of remaining tasks.

*Proof.* Let us consider an optimal algorithm  $\mathcal{O}$  and its execution on an instance with n tasks denoted  $T_1, ..., T_n$ . We reorder the task executions performed by  $\mathcal{O}$  such as all executions of  $T_1$  are done first, then all executions of  $T_2$  are performed, and so on. (Note that we have taken an arbitrary ordering of the tasks.) The new execution order has exactly the same cost as the previous one because switching costs are null. Also, Assumption 3 has no impact on the solution. Therefore, the optimal sequence of voltages to try for task  $T_i$  (for any value  $1 \le i \le n$ ) is the sequence of voltages defined in Section 4, so for a single task. Let  $V_{\pi(1)}, ..., V_{\pi(m)}$  be this sequence. Then algorithm  $\mathcal{O}$ , being optimal, tried for each task this sequence of voltages, in increasing voltages, until success. We finally reorder, once again at no cost, the task executions performed by algorithm  $\mathcal{O}$ : first all the executions at voltage  $V_{\pi(1)}$ , that is, the execution of all tasks at  $V_{\pi(1)}$ ; then all executions at voltage  $V_{\pi(2)}$ , that is, the execution of all remaining tasks at voltage  $V_{\pi(2)}$ ; and so on. We have, hence, defined a level algorithm following the voltage sequence defined for a single task, and whose expected energy cost is the same as that of the optimal algorithm  $\mathcal{O}$ . 

# **Theorem 3.** With linear switching costs, level algorithms are dominant.

*Proof.* Let us consider any optimal algorithm  $\mathcal{O}$  and an instance with n tasks. Let  $V_{\ell}$  be the lowest voltage used by algorithm  $\mathcal{O}$  during the entire execution. Then, the total voltage switching cost incurred by  $\mathcal{O}$  is  $S^{\mathcal{O}} \geq s_{k,\ell} + s_{\ell,k}$ . (Note that we use  $s_{k,\ell} + s_{\ell,k}$  for clarity here, to emphasize that we switch down to  $V_{\ell}$  and back to  $V_k = V_{\text{TH}}$ , but remember that  $s_{k,\ell} = s_{\ell,k}$  by Assumption 4.)

Let us consider any level algorithm  $\mathcal{L}$  that starts by switching to voltage  $V_{\ell}$ . Then, whatever the voltages it uses among the voltages  $V_{\ell}$ ,  $V_{\ell+1}$ , ...,  $V_k$ , it incurs a total switching cost exactly equal to  $S = s_{k,\ell} + s_{\ell,k}$ , because switching costs are linear. Therefore, we can assume without loss of generality that algorithm  $\mathcal{L}$  switches to all the voltages  $V_{\ell}, V_{\ell+1}, ..., V_k$  (maybe without executing any task at some of those levels). Then, the optimization problem to solve to determine at which next voltage should the remaining tasks be executed is exactly the same as if there were no switching costs (there is no penalty incurred when an intermediate voltage is used). Then, Lemma 2 tells us not only what is the optimal level algorithm in such a case but, also, that it is optimal among all existing algorithms. Hence, the optimality of  $\mathcal{L}$  among all algorithms using voltages among  $V_{\ell}$ ,  $V_{\ell+1}$ , ...,  $V_k$ . Because  $\mathcal{O}$  is one of these algorithms and is optimal, we can conclude.

**Theorem 4.** To execute a set of n independent tasks on a system with k voltages and linear switching costs, the optimal solution can be obtained with complexity  $O(k^2)$ .

*Proof.* According to Theorem 3, we only need to focus on level algorithms to obtain the optimal solution.

Suppose that a level algorithm starts executing the tasks at voltage  $V_h$ . Then, the total switching cost paid

by the algorithm during the entire execution is given by  $s_{k,h} + s_{h,k}$ , which is fixed and does not depend on the sequence of voltages used. It remains to find the optimal expected energy consumption to execute the tasks from  $V_h$  without considering the voltage switching costs. When there are no voltage switching costs, let  $\bar{E}_{\text{SET}}^*(i, V_h, V_\ell)$  and  $\bar{E}_{\text{ONE}}(V_h, V_\ell)$  denote, respectively, the optimal expected energy to execute *i* tasks and one task by starting from voltage  $V_h$ , given that all of them have previously failed under voltage  $V_\ell$ . We have  $\bar{E}_{\text{SET}}^*(n, V_h, V_0) = n \cdot \bar{E}_{\text{ONE}}^*(V_h, V_0)$ . We can then try all possible starting voltages to get the optimal expected total energy consumption as follows:

$$E_{\text{SET}}^* = \min_{1 \le h \le k} \left\{ s_{k,h} + s_{h,k} + n \cdot \bar{E}_{\text{ONE}}^*(V_h, V_0) \right\} \,,$$

and the optimal starting voltage is therefore  $V_{h'}$ , where  $h' = \arg \min_{1 \le h \le k} \{s_{k,h} + s_{h,k} + n \cdot \bar{E}^*_{\text{oNE}}(V_h, V_0)\}.$ 

Lemma 2 also shows that the optimal sequence of voltages to follow is the same as the optimal sequence to execute one task without considering voltage switching costs. According to Theorem 1, this can be computed by

$$\bar{E}_{\text{ONE}}^*(V_\ell) = \min_{\ell < h \le k} \bar{E}_{\text{ONE}}^*(V_h, V_\ell) \; ,$$

and  $\bar{V}_{\text{ONE}}^*(V_\ell) = V_{h'}$  with  $h' = \arg\min_{\ell < h \le k} \bar{E}_{\text{ONE}}^*(V_h, V_\ell)$ . The complexity is determined by the computation of  $\bar{E}_{\text{ONE}}^*(V_h, V_\ell)$  for all  $0 \le V_\ell < V_h \le V_k$ , which takes  $O(k^2)$  time.

In the general case, we will have triangle inequality but not triangle equality. We have not been able to design a counter-example to the optimality of level algorithms in the general case. We therefore conjecture the dominance of level algorithms.

## 6 Simulations

In this section, we evaluate the performance of the proposed algorithms using simulations. We instantiate the performance model with two scenarios. The first scenario is based on the available data about timing error probabilities on a specific hardware [5], and we consider a set of matrix products using ABFT as the verification mechanism. In the second scenario, we use synthetic data to assess the impact of different parameters (e.g., verification cost, error probability, switching cost) on alternative hardware and applications.

#### 6.1 Comparing algorithms

We compare our dynamic programming algorithm designed for a set of independent tasks, which we denote by *DP-indep*, to the following algorithms in the evaluation.

• Baseline & Threshold: These two are static algorithms that use the *environmental margin* voltage and *nominal* voltage, respectively, to execute the tasks.

The former does not make use of any voltage scaling technique, and the latter scales the voltage using near-threshold computing. Both algorithms do not incur errors and hence do not require verification and re-execution.

• *DP-single*: This algorithm uses the dynamic programming solution for a single task and applies the optimal sequence of voltages to execute all tasks in the set one after another, using the output voltage of the last task as the input voltage for the current task.

#### 6.2 Matrix Multiplication on FPGA

In the first evaluation scenario, we consider a concrete application (matrix multiplication) executed on a specific platform, where error probabilities are known from real measurements.

#### 6.2.1 Platform setting

We adopt the set of voltages and error probabilities measured by Ernst et al. [5] on an FPGA multiplier block. Figure 1 shows the error probability  $p_{\ell}^{(1)}$  of each available voltage  $V_{\ell}$  when performing a *single* operation with random inputs. We take the zero margin 1.54V as the nominal voltage and consider the environmental margin 1.69V as the base operating voltage. As in [3], we scale the error probabilities down by a factor of 10 to account for the circuit-level error recovery technique [5]. Since the dynamic power consumption is a quadratic function of the operating voltage [2, 12], for a given voltage  $V_{\ell}$ , the energy consumed to execute a task (one matrix product) is modeled as  $c_{\ell} = V_{\ell}^2 w$ , where w denotes the total number of operations in the task. The energy to switch the operating voltage is assumed to be linear (thus following triangle equality), and it is modeled as  $s_{\ell,h} = \beta \cdot \frac{|V_{\ell} - V_h|}{|V_k - V_1|}$ , where  $\beta$  captures the relative cost of voltage switching in comparison to computation.

#### 6.2.2 Application modeling

We consider the computation of a set of matrix products of the same size, which forms a set of independent tasks of same computation cost. Each product consist of  $m^3$  multiply-add operations, where m denotes the size of the matrices. To detect errors we employ Algorithm-Based Fault Tolerance (ABFT) [8], which uses checksums to detect, locate and even correct errors in many linear algebra kernels. Specifically, by adding one (column or row) checksum to each of the input matrices, the technique enables to detect and correct up to one error during the computation of a matrix product with an overhead of  $O(m^2)$  additional operations. This is almost negligible compared to the  $O(m^3)$  operations incurred by the raw computation for reasonable matrix sizes. In the simulation, we fix the matrix size to be m = 64, so the ABFT version has  $w = m(m+1)^2 = 64 \times 65^2$  operations, incurring an overhead of about 3%. With the ability to correct one error, the probability of having an incorrect product using voltage  $V_{\ell}$  is thus given by  $p_{\ell} = 1 - \left(1 - p_{\ell}^{(1)}\right)^w - {w \choose 1} \left(1 - p_{\ell}^{(1)}\right)^{w-1} p_{\ell}^{(1)}$ .

#### 6.2.3 Results

Figure 2 presents the impact of the number of tasks non the expected energy consumptions when the voltage switching cost  $\beta$  is set to be equivalent to multiplying two matrices of size  $64 \times 64$ , which is almost the cost of one task. When the number of tasks is small (e.g., less than 7), the switching cost can not be amortized and the best choice is to stay at nominal voltage. Additionally, the cost of the verification mechanism (ABFT) when m = 64 reaches 3% of the total work and both *DP-single* and *DP-indep* remain worse than executing all tasks at nominal voltage and without any verification mechanism. However, when the number of tasks is large enough (e.g., more than 7), DP-indep quickly outperforms DP-single, which only focuses on one task at a time and is thus unable to lower the voltage if it is not worth it for at least one task. On the contrary, DP-indep is paying the switching cost only once and it is easily amortized over the execution of the entire set of tasks.

Figure 3 shows the impact of the switching cost  $\beta$  on the expected energy consumption of *DP-single* and *DP-indep* under different switching costs when the number of tasks is fixed to 32. Again, we model the switching cost  $\beta$  to be equivalent to multiplying two matrices of size  $x \times x$ . The x axis shows the corresponding matrix size. When the switching cost is small (e.g., x = 20), both *DP-single* and DP-indep yield the same expected energy consumption. In fact, they are both able to amortize the switching cost with one task and they use the same sequence of voltages. But as the switching cost increases, *DP-single* quickly shows its limits while *DP-indep* manages to better amortize the overhead and remains better than *Threshold* even when the switching cost is more than three times the cost of one task (x > 96). Note that when the switching cost is high enough (e.g., x > 116), both algorithms are unable to perform better than *Threshold*.

Overall, when the number of tasks is large enough, or if the switching cost is small, DP-indep is always better and it saves up to 23% of the expected energy compared to the baseline algorithm in this configuration.

#### 6.3 Synthetic data

We now consider synthetic input data in order to evaluate the algorithms on different hardware and applications. We envision platforms with normalized voltages falling in [0.5, 1], where 1 represents the nominal voltage  $V_k$ . Following the characteristics of soft errors [6], we model the error probability of a computation of length wexecuted using voltage  $V_{\ell}$  to be  $p_{\ell} = 1 - e^{-\lambda_{\ell} w}$ , where

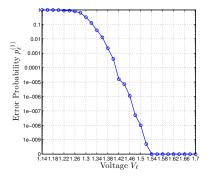


Figure 1: Error probabilities of available voltages measured on an FPGA multiplier block, for a single operation with random inputs [5].

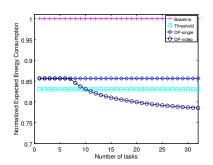


Figure 2: Impact of the switching cost  $\beta$  on the energy consumption of the algorithms.

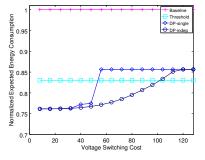


Figure 3: Impact of the number of tasks n on the energy consumption of the algorithms.

 $\lambda_{\ell} = \lambda_0 e^{-c(V_{\ell}-V_k)} - \lambda_0$  represents the error rate and c denotes the failure rate coefficient that depends on the hardware. The model specifies the base error rate  $\lambda_0$ , which is usually very small. In the experiments,  $\lambda_0$  is fixed at  $10^{-5}s$  (less than one error per day). The energy consumption to execute tasks and voltage switching costs follow the same model as in the previous scenario.

#### 6.3.1 Results

For each experiment, the total work is fixed to W = 10000 operations and the number of tasks is fixed at n = 32, so that each task has about  $\frac{10000}{32} \approx 312$  operations.

Figure 4(a) shows, given a voltage, the probability of failure for one task under different failure rate factors c. This factor determines how *fast* the probability of failure increases when the voltage is decreased below threshold. A small value for c shows a very optimistic configuration where lowering the voltage below threshold is possible while keeping low probabilities of failure. Such a configuration is ideal and allows us to choose amongst a wide range of voltages, thus giving the opportunity to save energy. Higher values for c shows more realistic, and also more pessimistic configurations. When c is high (e.g., 128), as soon as we lower the voltage, the probability of failure increases dramatically and the chances of success drop close to zero. In that case, *DP-indep* has no other choice but to stay at nominal voltage.

Figure 4(b) presents the impact of the number of tasks on the normalized expected energy consumption of DP-indep with respect to Threshold when the total work W is fixed to 10000 and for different values of c. When the number of task decreases, the size of the tasks increases and the probability of success for one task drops considerably. As a result, we have to use higher voltages, which consumes more energy.

The value of c determines the range of voltages that can be used safely, i.e., with low probability of failure, as shown by Figure 4(a) and it has a huge impact on the expected energy consumption. Under a small c, the algorithm can yield important energy savings compared to *Threshold* (more than 40% for 10 tasks with c = 4 under this configuration), while with a large c (e.g., c = 128) the algorithm will not be able to do better than *Threshold*.

Finally, Figure 4(c) evaluates the impact of the verification cost on the expected energy consumption of DP-indep. In this experiment, we make the verification cost vary with respect to the cost of one task from 0% (no verification cost) to 100% (the verification cost is equivalent to the cost of one task). When the cost of the verification increases, so does the total overhead of the computation. Consider the case where the cost of the verification is half the cost of one task (i.e., total work including verifications is now 1.5W). Then, executing 256 tasks is 40% better than Threshold, whereas under the same configuration, executing only 32 tasks for the same amount of work is only 5% better than Threshold. Overall, we observe that the execution of a lot of small tasks is preferred over a few big tasks.

#### 6.3.2 Optimal solution with two different voltages

We now consider a set of scenarios where only two voltages are available,  $V_1$  and  $V_k = V_{\text{TH}}$ . As shown previously, the only decision to make is whether to switch to the lower voltage  $V_1$ , in which case a cost of  $2s_{k,1}$  is incurred due to voltage switching, or to directly use the nominal voltage  $V_k$ for executing the tasks. Figure 5 shows the energy savings achieved by the optimal algorithm (DP-indep). Naturally, more energy is saved when  $V_1$  has a smaller execution cost or a lower error probability. For any given cost and probability, the saving also increases with the number of tasks, because the cost of voltage switching can be better amortized. For the case with 10 tasks and  $s_{k,1} = 5c_1$ , and when the error probability of voltage  $V_1$  is around 0.5, *DP-indep* starts to save energy when the cost  $c_1$  drops below  $c_k/3$ , and it is able to save at least 40% of the energy with a cost lower than  $c_k/10$ .

For the same case (10 tasks and  $s_{k,1} = 5c_1$ ), Figure 6

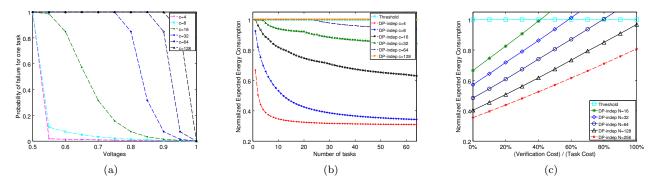


Figure 4: Impact of failure rate factor c ((a) and (b)), and of the cost ratio of verification (c), on the expected energy consumption.

shows the performance degradation (expected execution time overhead) due to verification and re-execution. Since the results are obtained for *DP-indep*, which targets energy minimization, they do not represent the best performance. Indeed, the overhead is minimum (0%) when the algorithm does not switch to  $V_1$ , which means that no energy is saved at all. Once the algorithm has decided to make the switch to save energy, the expected performance starts to degrade. For any fixed cost ratio  $c_k/c_1$ , however, a lower error probability enables the algorithm to both save energy and improve performance, because tasks enjoy a higher chance of success at  $V_1$ . Finally, as verification and/or voltage switching times increase, the performance degrades further. For instance, when  $p_1 = 0.5$  and  $c_k/c_1 = 10$ , and when verification takes 5% of the task execution time and voltage switching takes the same time as task execution, the algorithm achieves 40% of the energy at the expense of about 70% degradation in performance.

## 7 Conclusion

In this paper, we have used voltage overscaling to design a purely software-based approach for reducing the energy consumption of HPC applications. This approach aggressively lowers the supply voltage below the nominal voltage, introducing timing errors. Based on a formal model of timing errors, we have provided an optimal level algorithm to schedule independent tasks, and we have proven its global optimality when switching costs are linear. The evaluation results obtained both for matrix multiplication on FPGA and for synthetic data demonstrate that our approach can indeed lead to significant energy savings compared to the standard algorithm that always operates at (or above) the nominal voltage. The results are quite promising, and we plan to extend this approach to more complicated application workflows in the future.

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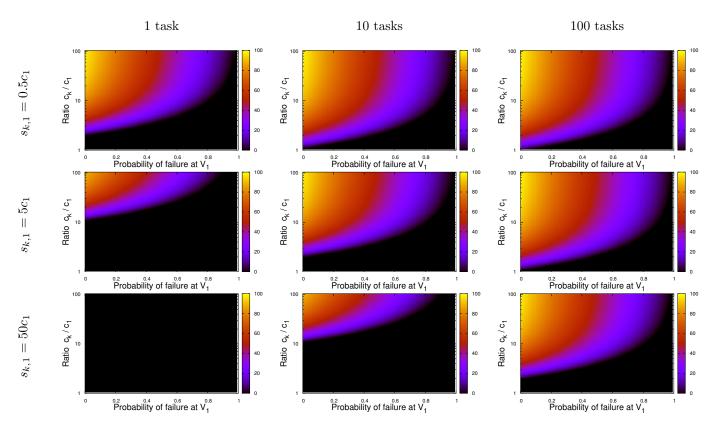


Figure 5: Impact of the switching cost and of the number of tasks on the percentage of energy saving when only two voltages are available. Black means no saving, and yellow means 100% of energy is saved.

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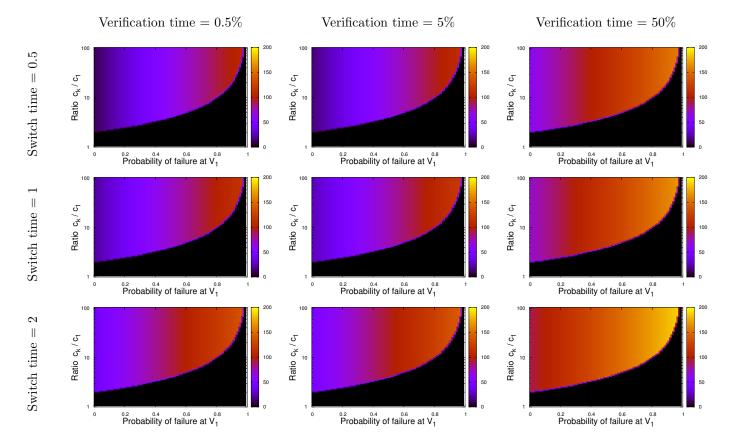


Figure 6: Percentage of (expected) execution time overhead as a function of the probability of failure and of the ratio of energy costs. Examples with 10 tasks and a switching energy cost of  $5c_1$ . The unit used to express the verification and switching times is the execution time of a task (at voltage  $V_k$ ).



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